Electrical Instrumentation/ Applied Measurements

FOR WHOM INTENDED Engineers, scientists, and managers, as well as aides and technicians. This course will be of interest to personnel involved in making or understanding experimental test measurements. Some background in electronics is helpful but is not essential. The course will be tailored to student objectives.

OBJECTIVES This course provides a basic understanding of electrical measurement systems, as well as the engineering concepts for the whole measurement system. It provides an introduction to the many varieties of meters, 'scopes and transducers available, their operating principles, strengths and weaknesses. A variety of measurands and device types is covered, as well as signal conditioning, recording and analysis. It covers climatic measuring systems and reviews dynamic theory, which is essential for a better understanding of the measurand under consideration.

One of the course objectives is to give students enough applications information that they can select optimum meters, transducer, amplifier, recording and readout devices to assemble a system for routine measurements of electrical phenomena. The problems of signal noise, accuracy and error are covered in some depth before continuing on to spectral analysis, sampling and discussion of aliasing problems, filter types and antialiasing solutions.

The uncertainty surrounding the value of the measurand is discussed and an introduction to statistics as applied to engineering is covered.

One of the most difficult tasks for the measurement engineer is the selection of the proper instrumentation system. A procedure for attaining this goal is discussed and a typical instrumentation selection list developed.

While calibration is beyond the scope of this course, a procedure for calibrating a sensor device is provided as an appendix

BRIEF DESCRIPTION OF COURSE Mainly lectures, supported by slides, transparencies, videos and sample hardware. Students are expected to participate in classroom discussions, as well as read text materials and class notes.

The course utilizes a non-mathematical approach to understanding concepts and mechanisms.

Participants are encouraged to bring a specific measurement problem to class for discussion.

DIPLOMA PROGRAMS This course is required for TTi's Electronic Design Specialist (EDS) and Mechanical Design Specialist (MDS) Diploma Programs. It satisfies the course 164 or 166 requirement(s) for TTi's Data Acquisition & Analysis Specialist (DAAS), Electronic Telecommunications Specialist (ETS), Instrumentation Test Specialist (ITS) and Metrology/Calibration Specialist (MCS) Diploma Programs, and may be used as an elective for any other TTi diploma program.

RELATED COURSES Course 164/166 combines Course 164, Electrical Instrumentation for Test & Measurement with course 166, Applied Measurements. Course 163 covers some of the same material, with more emphasis on dynamics.

PREREQUISITES there are no definite prerequisites, but participation in TTi's course "Electronics for Non-Electronic Engineers" or the equivalent would be helpful.

TEXT Each student will receive 180 days access to the on-line electronic course workbook. Renewals and printed textbooks are available for an additional fee.

COURSE HOURS, CERTIFICATE AND CEUs Class hours/days for on-site courses can vary from 21–35 hours over 3–5 days as requested by our clients. Upon successful course completion, each participant receives a certificate of completion and one Continuing Education Unit (CEU) for every ten class hours.

INTERNET COMPLETE COURSE 166/164 features over 14 hours of video as well as more in-depth reading material. All chapters of course 166/164 are also available as OnDemand Internet Short Topics. See the online course outline for details.



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Electrical Instrumentation/ Applied Measurements Course Outline No. 164/166

Part I: Instrumentation for Electrical Test & Measurement

- Introduction: Accurate Measurements Sensors and Systems Components of an Instrumentation System Functional Components of a Measurement Chain Basic Radio Telemetry System • Carrier Modulation
- Types of Data Signals: periodic, sinusoidal, complex, square, transient, random • Power Spectral Density • Average, peak and root-mean-square values

Digital measurement systems • Nomenclature, Codes Noise: Gaussian Distribution • Weak Signal • Noise Calculations Suppression for Sensor Signals • Noise Figure and Distortion Electronic Noise Measurements • Phase Noise Noise Types: Shot (or Schottky), Thermal (or Johnson), Flicker

(1/f), Burst, Avalanche • Noise as a Vector • Noise Colors Understanding decibels and Octaves • Logarithmic scale in graphs

Parameters of linear systems • Non-linearity and Distortion • Filters Accuracy and Error: Accuracy, Calibration and Error Assessment

- Common Terms: Accuracy, Calibration and Error Assessment Common Terms: Accuracy vs. Precision • Classification of Errors Error Assessment • Improper Functioning of Instruments Effect of Transducer on Process • Dual Sensitivity Errors Minimizing Error
- Electrical laboratory practice: Safety Grounds Circuit protection devices • Input impedance, output impedance and loading Power transfer and impedance matching
- Analog and Digital DC and AC meters
- DC and AC ammeters and voltmeters Analog multimeters How to use basic meters • Meter errors • Digital Electronic Meters
- Digital Multimeter Operation: Agilent 3458A Digital Multimeter
- Making Measurements with a Digital Multimeter: Voltage, Current, Resistance • A/D and D/A conversion • Identifying Resistors Guarded Voltmeter (optional):

Shields, Grounded measurement, Bridges

Oscilloscopes: Making measurements—Voltage, Time, Frequency, Phase, Pulse • Lissajous patterns Digital Oscilloscopes

Time and frequency measurements

Power and energy measurements: Power in AC circuits Single-phase measurements • Polyphase • Higher frequencies

- Wheatstone Bridges: Basic Laws of Networks Voltage Divider Circuit • Methods of Measurement • Voltage-Sensitive and Current-Sensitive Bridges • Constant-Current Bridges • Bridge Sensitivity • Three-Wire Bridge • Effects of Temperature • Shunt Calibration • Voltage Insertion Calibration • Strain Gage Compensation • AC Bridges—Classic Inductance, Capacitance Bridges
- DC and AC signal sources: Batteries DC power supplies: How to use • Oscillators Sweep-frequency generators • Pulse generators Function generators
- Sensors/Transducers: Strain gauges, Silicon Transducer Principles • Accelerometers • LVDT • Potentiometric and Piezoelectric Transduction

Part II: Applied Measurements

Introduction to Measurement Engineering: Definitions Preparing to Make Measurements • Open and Closed Loop Systems • Analog and Digital • Transfer of Energy Measurement System Responses

Climatic Measurements: Temperature • Humidity • Pressure • Flow

Review of Dynamic Theory: Laws of Motion Weight, Mass and Gravity • Force, Mass and Acceleration Work, Power • Energy • Linear, Angular Displacement, Velocity Tangential Acceleration • Torque • Stress and Strain Simple Tension or Compression • Shear Strain

Reducing Signal Noise: Unwanted Signals • Shield Strategies Twisted Pair • Electrical Noise: High Signal Source Impedance Low Signal Source Impedance • Source Shunting • Parallel Conductors • Twisted Conductors • Microvolt Signal Cables Ground Loops • Eliminating Multiple Grounds • Stable System Ground • Amplifier Guard Shield • Common-Mode Rejection Spectral and Fourier Analysis: Spectral Analysis Sinusoidal, Complex and Random Signals • Phase of Frequency Domain Components • Time and Frequency Domain Fourier Analysis • Adding Two Signals-Using RMS Values The Fourier Transform • Discrete Fourier Analysis • FFT Classification of Types of Data • Random Signals • Correlation Cross-Correlation, Coherence • Auto Spectral Density (ASD) Power Spectral Density • Calculating RMS From PSD Signal Analysis and Aliasing: Signal Acquisition Shannon's Theorem and Corollaries • Aliasing Viewed as Folding Where Does the Aliased Data Appear? Example .. Sine Signal • Aliasing/Multiple Folding Digitizing "Rules" • Interpolation .. When is it Needed? Filters: Integrating and Differentiating Circuits • Acoustic Weighting Bandpass Filter • Undamped (high Q) vs. Damped (low Q) Filters Selective Filtering • Characteristics of Butterworth, Chebyshev and Bessel Filters • RC and LR Circuits Anti-Alias Filters • Brick-Wall vs Real Filters • Aliasing Analysis Anti-Alias Filters-Hardware • Filter "Construction" How Filters Behave • Group Delay • Filter Cutoff Frequency Sampling Ratio Calculation • FR/FD Ratio Measurement Uncertainty and Introduction to Statistics Error and Uncertainty . ISO Definitions Simple Statistics of Measurement • Probability-Definitions Data Distributions • Cumulative Frequency Curve Summation Degrees of Freedom (v) • Mean, Median and Mode Standard Deviation (s or σ) • Variance (s²) • Normal Distribution Gaussian Curve • Confidence • Gaussian (s-Normal) Distribution Special Definitions for Random Vibration • Computing the Standard Deviation—Example • Confidence Levels Type B — Evaluations other than Statistical Summary, Final Quiz

Award of Certificates for Successful Completion

Appendix: Glossary of Terms

Standard Deviation Calculation Worksheet Typical Instrumentation Selection Check List Transducer Calibration • Analog Oscilloscope Controls ASCII codes



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